

# English Test for Admission in 2020 (including Admission in October 2019)

December 2018

Graduate School of Information Science and Technology, Osaka University

## ○ Pure and Applied Mathematics

An English test is provided (No TOEIC or TOEFL scores will be considered.)

Selection for Information Technology Special Course in English (June) will NOT be conducted.

## ○ Information and Physical Sciences

TOEIC or TOEFL scores will be considered in lieu of an English test.

For Master Course General Selection in August, Special Selection for Juniors of Undergraduate Schools, Special Selection for International Applicants, **an official score certificate for TOEIC or TOEFL dated after July 2017** is required. Please check the date of your TOEIC or TOEFL test. If you have not taken any of these tests, please take them at an early date to make it to **the application acceptance period or on the first day of the Entrance Examination.**

**For Selection for Information Technology Special Course in English (June), TOEIC or TOEFL scores will be considered in lieu of an English test. An official score certificate for TOEIC or TOEFL dated after May 2017 is required. Please check the date of your TOEIC or TOEFL test. If you have not taken any of these tests, please take them at an early date to make it to the Pre-Application Screening.**

When submitting an official score certificate, “**Official Score Certificate**” for TOEIC or “**Test Taker Score Report**” (or “**Examinee Score Report**”) for TOEFL must be submitted.

Scores from TOEIC Institutional Programs and TOEFL Institutional Testing Programs, TOEIC Speaking & Writing Tests, TOEIC Speaking Test, and TOEIC Bridge Test are not acceptable.

**For Special Selection for International Applicants and for Selection for Information Technology Special Course in English (June), some applicants may not be required to submit a TOEIC/TOEFL score certificate.**

For example, a native English speaker or a student who has graduated from or who is expected to graduate from an institution where all instruction is in English.

**Such an applicant should consult with his/her intended academic supervisor, prior to submission of the application form, to verify that a TOEIC/TOEFL score certificate can be waived from application requirement.**

- **Computer Science**
- **Information Systems Engineering**
- **Information Networking**
- **Multimedia Engineering**
- **Bioinformatic Engineering**

TOEIC scores are considered in lieu of an English test.

For Master Course General Selection in August, Special Selection for Juniors of Undergraduate Schools, and Special Selection for International Applicants, **an official score certificate for TOEIC dated after July 2017** is required. Please check the date of your TOEIC test. If you have not taken TOEIC test, please take it at an early date to make it to **the application acceptance period or on the first day of the Entrance Examination. However, an official score certificate for TOEFL dated after July 2017 is also acceptable in case it's difficult to submit TOEIC score.**

**For Selection for Information Technology Special Course in English (June), TOEIC or TOEFL scores will be considered in lieu of an English test. An official score certificate for TOEIC or TOEFL dated after May 2017** is required. Please check the date of your TOEIC or TOEFL test. If you have not taken any of these tests, **please take them at an early date to make it to the Pre-Application Screening.**

When submitting an official score certificate, **“Official Score Certificate”** for TOEIC or **“Test Taker Score Report”** (or **“Examinee Score Report”**) for TOEFL must be submitted.

Scores from TOEIC Institutional Programs and TOEFL Institutional Testing Programs, TOEIC Speaking & Writing Tests, TOEIC Speaking Test, and TOEIC Bridge Test are not acceptable.

**For Special Selection for International Applicants and for Selection for Information Technology Special Course in English (June), some applicants may not be required to submit a TOEIC/TOEFL score certificate.**

For example, a native English speaker or a student who has graduated from or who is expected to graduate from an institution where all instruction is in English.

**Such an applicant should consult with his/her intended academic supervisor, prior to submission of the application form, to verify that a TOEIC/TOEFL score certificate can be waived from application requirement.**

Note1: Submit your TOEIC/TOEFL certificates either **at the time you submit your application documents or at the examination room on the first day of the entrance examination under the instruction of the examiners.** However, you may re-submit scores on the day of the entrance examination even if you have already provided scores when you submitted your application **(it is necessary for the Pre-application screening of Selection for Information Technology Special Course in English (June)).**

Note2: For those who are taking other selections that are not mentioned above, refer to the corresponding admission guide regarding the English qualification exam.

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**TOEIC** is the acronym for the Test of English for International Communication. The TOEIC test is a global standard for the assessment of communicative English ability implemented in approx. 60 countries all over the world. Similar to TOEFL, it is developed and produced by the Educational Testing Service (ETS) (<http://www.ets.org/>). In Japan, it is implemented and operated by the Institute for International Business Communication (IIBC) (<http://www.toeic.or.jp/>).

**TOEFL** is the acronym for the Test of English as a Foreign Language. The TOEFL test is used to determine whether an applicant whose native language is not English, who wishes to enter an undergraduate or a graduate school in the US, has sufficient English proficiency and enough common knowledge to participate in classes there. Developed and produced by the Educational Testing Service (ETS). In Japan, it is implemented and operated by the Council on International Educational Exchange (CIEE) Japan (<http://www.cieej.or.jp/>).